

Search Notes

Application/Control No.

10/801,567

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under
Reexamination

YOSHIKAWA, NORIO

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
360	900 901 902 903	5/19/2006	MK
360	904	5/19/2006	MK
360	132	5/19/2006	MK
369	80	5/19/2006	MK
720	645	5/19/2006	MK
720	655	5/19/2006	MK
360	97.01	5/22/2006	MK
360	97.02	5/22/2006	MK
360	97.03	5/22/2006	MK
206	308.1	5/22/2006	MK
206	303 310	5/23/2006	MK
220	4.21 4.22	5/23/2006	MK
220	608 669	5/23/2006	MK
220	670 307	5/23/2006	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
360	97.01	5/22/2006	MK
360	97.02	5/22/2006	MK
360	132	5/19/2006	MK
EAST (USPG-PUB)		5/23/2006	MK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search Notes)	5/19/2006	MK
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search Notes)	5/22/2006	MK
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search Notes)	5/23/2006	MK
Contacted Senior Primary Examiner David Fidei (classes 206 & 220)	5/22/2006	MK